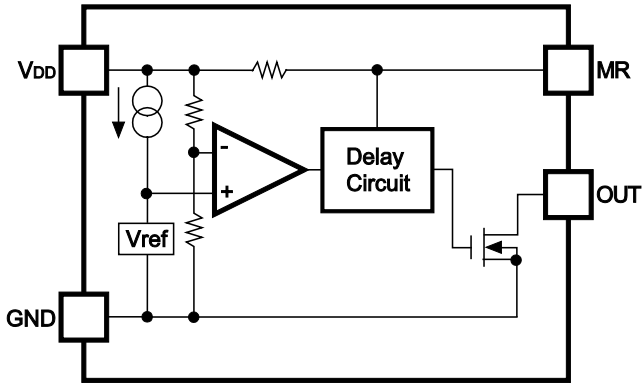


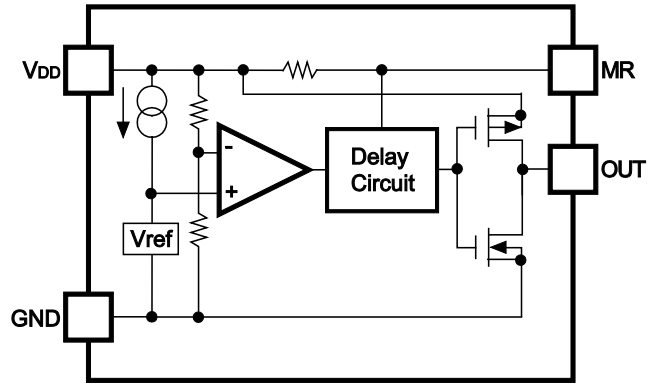
R3132x/R3133x

BLOCK DIAGRAMS

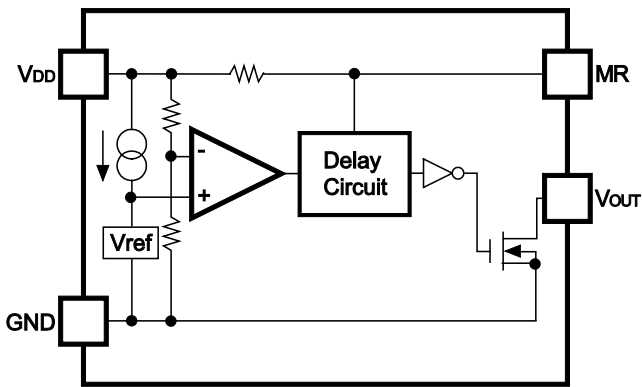
R3132xxxEA Nch Open Drain Output



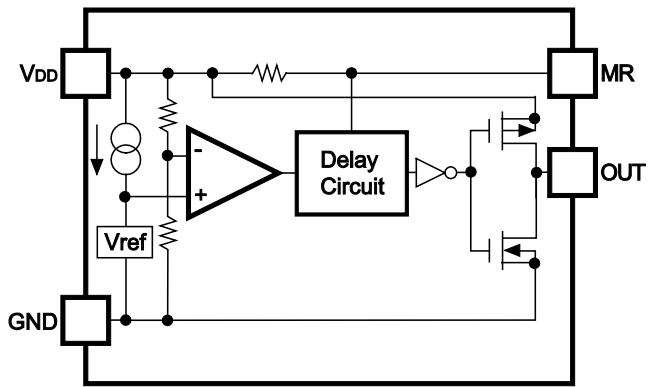
R3132xxxEC CMOS Output



R3133xxxEA Nch Open Drain Output



R3133xxxEC CMOS Output



\* R3133Q (SC-82AB) is the discontinued product as of March, 2016.

R3132x/R3133x

## SELECTION GUIDE

The package type, the detector threshold, the output type and the taping type for the ICs can be selected at the users' request.

Product Name	Package	Quantity per Reel	Pb Free	Halogen Free
R3132DxxE*(y)-TR-FE R3133DxxE*(y)-TR-FE	SON1612-6	4,000 pcs	Yes	Yes
R3132QxxE*(y)-TR-FE R3133QxxE*(y)-TR-FE	SC-82AB	3,000 pcs	Yes	Yes

xx: The detector threshold can be designated in the range from 1.0V(10) to 5.0V(50) in 0.1V steps.

y: If the detector threshold includes the 3rd digit, indicate the digit of 0.01V.

(2.32V, 2.63V, 2.93V, 3.08V, 4.38V, 4.63V)

Ex. If the detector threshold is 2.63V, R3132x26E\*3-TR-FE.

\* : Designation of Output Type

(A) Nch Open Drain

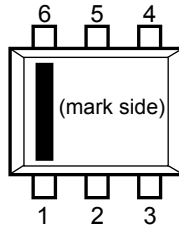
(C) CMOS

\* R3133Q (SC-82AB) is the discontinued product as of March, 2016.

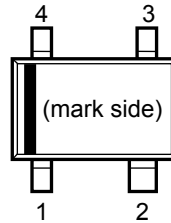
R3132x/R3133x

**PIN CONFIGURATIONS**

• SON1612-6



• SC-82AB



**PIN DESCRIPTIONS**

• SON1612-6

Pin No	Symbol	Pin Description
1	V <sub>DD</sub>	Input Pin
2	GND	Ground Pin
3	MR	Manual Reset Input Pin Active at "L" input. Pulled up via 1MΩ. If MR pin is not necessary, open this node, or connect to V <sub>DD</sub> .
4	OUT	Output Pin R3132D Series:"L" at detection R3133D Series:"H" at detection
5	GND	Ground Pin
6	NC	No Connection

• SC-82AB

Pin No	Symbol	Pin Description
1	GND	Ground Pin
2	OUT	Output Pin R3132Q Series : "L" at detection R3133Q Series : "H" at detection
3	MR	Manual Reset Input Pin Active at "L" input. Pulled up via 1MΩ. If MR pin is not necessary, open this node, or connect to V <sub>DD</sub> .
4	V <sub>DD</sub>	Input Pin

## ABSOLUTE MAXIMUM RATINGS

Symbol	Item	Rating	Unit
$V_{DD}$	Supply Voltage	6.5	V
$V_{OUT}$	Output Voltage (Nch Open Drain Output)	$V_{SS}-0.3$ to 6.5	V
	Output Voltage (CMOS Output)	$V_{SS}-0.3$ to $V_{DD}+0.3$	
$V_{MR}$	Input Voltage	$V_{SS}-0.3$ to $V_{DD}+0.3$	V
$I_{OUT}$	Output Current	20	mA
$P_D$	Power Dissipation (SON1612-6)*1, *2	500	mW
	Power Dissipation (SC-82AB)*2	380	
$T_{opt}$	Operating Temperature Range	-40 to 85	°C
$T_{stg}$	Storage Temperature Range	-55 to 125	°C
$T_{solder}$	Soldering Temperature	260°C, 10s	

\*1) This specification is at mounted on board.

$P_D$  depends on conditions of mounting on board. This specification is based on the measurement at the condition below:

\*Measurement Conditions

Environment: Mounted on board (Wind velocity 0m/s)

Board Material: FR-4 (2-layer)

Board dimensions : 40mm x 40mm x t1.6mm

Copper Area : 50%

\*2) For Power Dissipation, please refer to PACKAGE INFORMATION.

### ABSOLUTE MAXIMUM RATINGS

Electronic and mechanical stress momentarily exceeded absolute maximum ratings may cause the permanent damages and may degrade the life time and safety for both device and system using the device in the field. The functional operation at or over these absolute maximum ratings is not assured.

\* R3133Q (SC-82AB) is the discontinued product as of March, 2016.

## R3132x/R3133x

### ELECTRICAL CHARACTERISTICS

T<sub>opt</sub>=25°C

Symbol	Item	Test Conditions	Min.	Typ.	Max.	Unit	
V <sub>DD</sub>	Operating Voltage	R3132	T <sub>opt</sub> =25°C	0.75		6.0	V
			-40°C≤T <sub>opt</sub> ≤85°C	0.85		6.0	
		R3133	T <sub>opt</sub> =25°C	0.80		6.0	
			-40°C≤T <sub>opt</sub> ≤85°C	0.90		6.0	
V <sub>DET</sub>	Detector Threshold		V <sub>DET</sub> × 0.98		V <sub>DET</sub> × 1.02	V	
I <sub>SS1</sub>	Supply Current1	V <sub>DD</sub> =V <sub>DET</sub> -0.1V, I <sub>OUT</sub> =0A			2.0	μA	
I <sub>SS2</sub>	Supply Current2	V <sub>DD</sub> =V <sub>DET</sub> +0.1V, I <sub>OUT</sub> =0A			2.0	μA	
I <sub>SS3</sub>	Supply Current3	V <sub>DD</sub> =6.0V, I <sub>OUT</sub> =0A	V <sub>DET</sub> <1.6V			3.6	μA
			1.6V≤V <sub>DET</sub> <2.7V			3.0	
			2.7V≤V <sub>DET</sub>			2.5	
V <sub>OH</sub>	"H" Output Voltage	Refer to the following table.					
V <sub>OL</sub>	"L" Output Voltage	Refer to the following table.					
R <sub>MR</sub>	MR pin pull-up resistance	T <sub>opt</sub> =25°C	0.5	1.0	4.0	MΩ	
T <sub>rst</sub> *	Output Delay Time for detect	V <sub>DD</sub> =V <sub>DET</sub> to V <sub>DET</sub> -0.1V		15		μs	
T <sub>delay</sub>	Output Delay Time for release	V <sub>DD</sub> =0.8V to V <sub>DET</sub> +1.0V	204	240	276	ms	
ΔV <sub>DET</sub> / ΔT <sub>opt</sub>	Detector Threshold Temperature Coefficient	-40°C≤T <sub>opt</sub> ≤85°C		±100		ppm/ °C	

\*) Guaranteed by design, not mass production tested.

#### RECOMMENDED OPERATING CONDITIONS (ELECTRICAL CHARACTERISTICS)

All of electronic equipment should be designed that the mounted semiconductor devices operate within the recommended operating conditions. The semiconductor devices cannot operate normally over the recommended operating conditions, even if when they are used over such conditions by momentary electronic noise or surge. And the semiconductor devices may receive serious damage when they continue to operate over the recommended operating conditions.

• "H" Output Voltage ( $V_{OH}$ ) table

$T_{opt}=25^{\circ}C$

Products	Test Conditions		Min.	Typ.	Max.	Unit
R3132xxxEC	$V_{DET}<1.2V$	$V_{DD}=V_{DET}+0.1V, I_{OH}=-50\mu A$	$0.8 \times V_{DD}$			V
	$1.2V \leq V_{DET} < 2.0V$	$V_{DD}=V_{DET}+0.1V, I_{OH}=-150\mu A$				
	$2.0V \leq V_{DET} < 3.1V$	$V_{DD}=V_{DET}+0.1V, I_{OH}=-500\mu A$				
	$3.1V \leq V_{DET}$	$V_{DD}=V_{DET}+0.1V, I_{OH}=-800\mu A$				
R3133xxxEC	$V_{DET}<1.2V$	$V_{DD}=V_{DET}-0.1V, I_{OH}=-10\mu A$	$0.8 \times V_{DD}$			V
	$1.2V \leq V_{DET} < 2.0V$	$V_{DD}=V_{DET}-0.1V, I_{OH}=-100\mu A$				
	$2.0V \leq V_{DET} < 3.1V$	$V_{DD}=V_{DET}-0.1V, I_{OH}=-500\mu A$				
	$3.1V \leq V_{DET}$	$V_{DD}=V_{DET}-0.1V, I_{OH}=-800\mu A$				

$V_{DET}$  is a set value.

• "L" Output Voltage ( $V_{OL}$ ) table

$T_{opt}=25^{\circ}C$

Symbol	Item	Test Conditions	Min.	Typ.	Max.	Unit
R3132xxxEx	$V_{DET}<1.2V$	$V_{DD}=V_{DET}-0.1V, I_{OL}=20\mu A$			0.3	V
	$1.2V \leq V_{DET} < 1.6V$	$V_{DD}=V_{DET}-0.1V, I_{OL}=750\mu A$				
	$1.6V \leq V_{DET} < 3.1V$	$V_{DD}=V_{DET}-0.1V, I_{OL}=1.2mA$			0.4	V
	$3.1V \leq V_{DET}$	$V_{DD}=V_{DET}-0.1V, I_{OL}=3.2mA$				
R3133xxxEx	$V_{DET}<1.2V$	$V_{DD}=V_{DET}+0.1V, I_{OL}=20\mu A$			0.3	V
	$1.2V \leq V_{DET} < 1.6V$	$V_{DD}=V_{DET}+0.1V, I_{OL}=750\mu A$				
	$1.6V \leq V_{DET} < 3.1V$	$V_{DD}=V_{DET}+0.1V, I_{OL}=1.2mA$			0.4	V
	$3.1V \leq V_{DET}$	$V_{DD}=V_{DET}+0.1V, I_{OL}=3.2mA$				

$V_{DET}$  is a set value.

\* R3133Q (SC-82AB) is the discontinued product as of March, 2016.

**R3132x/R3133x**

**DETECTOR THRESHOLD SPECIFICATIONS BY PART NUMBER**

• **R3132x**

Part Number	Operating Voltage				Detector Threshold			Supply Current 1		
	V <sub>DD</sub> [V]				V <sub>DET</sub> [V]			I <sub>SS1</sub> [μA]		
	Conditions	Min.	Conditions	Min.	Min.	Typ.	Max.	Conditions	Typ.	Max.
R3132x23Ex2	T <sub>opt</sub> =25°C	0.75	-40°C ≤ T <sub>opt</sub> ≤ 85°C	0.85	2.274	2.320	2.366	V <sub>DD</sub> =V <sub>DET</sub> -0.1V I <sub>OUT</sub> =0A	0.8	2.0
R3132x26Ex3					2.578	2.630	2.682			
R3132x29Ex3					2.872	2.930	2.988			
R3132x30Ex8					3.019	3.080	3.141			
R3132x43Ex8					4.293	4.380	4.467			
R3132x46Ex3					4.538	4.630	4.722			
R3132x10Ex	T <sub>opt</sub> =25°C	0.75	-40°C ≤ T <sub>opt</sub> ≤ 85°C	0.85	0.980	1.000	1.020	V <sub>DD</sub> =V <sub>DET</sub> -0.1V I <sub>OUT</sub> =0A	0.8	2.0
R3132x11Ex					1.078	1.100	1.122			
R3132x12Ex					1.176	1.200	1.224			
R3132x13Ex					1.274	1.300	1.326			
R3132x14Ex					1.372	1.400	1.428			
R3132x15Ex					1.470	1.500	1.530			
R3132x16Ex					1.568	1.600	1.632			
R3132x17Ex					1.666	1.700	1.734			
R3132x18Ex					1.764	1.800	1.836			
R3132x19Ex					1.862	1.900	1.938			
R3132x20Ex					1.960	2.000	2.040			
R3132x21Ex					2.058	2.100	2.142			
R3132x22Ex					2.156	2.200	2.244			
R3132x23Ex					2.254	2.300	2.346			
R3132x24Ex					2.352	2.400	2.448			
R3132x25Ex					2.450	2.500	2.550			
R3132x26Ex					2.548	2.600	2.652			
R3132x27Ex					2.646	2.700	2.754			
R3132x28Ex					2.744	2.800	2.856			
R3132x29Ex					2.842	2.900	2.958			
R3132x30Ex					2.940	3.000	3.060		0.9	
R3132x31Ex					3.038	3.100	3.162			
R3132x32Ex					3.136	3.200	3.264			
R3132x33Ex					3.234	3.300	3.366			
R3132x34Ex					3.332	3.400	3.468			
R3132x35Ex					3.430	3.500	3.570			
R3132x36Ex					3.528	3.600	3.672			
R3132x37Ex					3.626	3.700	3.774			
R3132x38Ex					3.724	3.800	3.876			
R3132x39Ex					3.822	3.900	3.978			
R3132x40Ex	3.920	4.000	4.080							
R3132x41Ex	4.018	4.100	4.182							
R3132x42Ex	4.116	4.200	4.284							
R3132x43Ex	4.214	4.300	4.386							
R3132x44Ex	4.312	4.400	4.488							
R3132x45Ex	4.410	4.500	4.590							
R3132x46Ex	4.508	4.600	4.692							
R3132x47Ex	4.606	4.700	4.794							
R3132x48Ex	4.704	4.800	4.896							
R3132x49Ex	4.802	4.900	4.998							
R3132x50Ex	4.900	5.000	5.100							

Supply Current 2			Supply Current 3			"H" Output Voltage	
Iss2[ $\mu$ A]			Iss3[ $\mu$ A]			Voh[V]	
Conditions	Typ.	Max.	Conditions	Typ.	Max.	Conditions	Min.
VDD=VDET+0.1V IOUT=0A	0.8	2.0	VDD=6.0V IOUT=0A	1.2	3.0	VDD=VDET+0.1V IOH=-500 $\mu$ A	0.8 $\times$ VDD
				1.0	2.5	VDD=VDET+0.1V IOH=-800 $\mu$ A	
VDD=VDET+0.1V IOUT=0A	0.8	2.0	VDD=6.0V IOUT=0A	1.4	3.6	VDD=VDET+0.1V IOH=-50 $\mu$ A	0.8 $\times$ VDD
						VDD=VDET+0.1V IOH=-150 $\mu$ A	
				1.2	3.0	VDD=VDET+0.1V IOH=-500 $\mu$ A	
						VDD=VDET+0.1V IOH=-800 $\mu$ A	
				1.0	2.5	VDD=VDET+0.1V IOH=-800 $\mu$ A	
						0.8	



\* R3133Q (SC-82AB) is the discontinued product as of March, 2016.

## R3132x/R3133x

Part Number	"L" Output Voltage		MR pin "H" Input Voltage		MR pin "L" Input Voltage		MR pin pull-up resistance											
	VOL[V]		VIH[V]		VIL[V]		RMR[MΩ]											
	Conditions	Max.	Conditions	Min.	Conditions	Max.	Conditions	Min.	Typ.	Max.								
R3132x23Ex2	VDD=VDET-0.1V IOL=+1.2mA	0.3	VDD≥VDET+0.1	0.75× VDD	VDD≥VDET+0.1	0.2× VDD	Topt=25°C	0.5	1.0	4.0								
R3132x26Ex3																		
R3132x29Ex3																		
R3132x30Ex8																		
R3132x43Ex8	VDD=VDET-0.1V IOL=+3.2mA	0.4	VDD≥VDET+0.1	0.75× VDD	VDD≥VDET+0.1	0.2× VDD	Topt=25°C	0.5	1.0	4.0								
R3132x46Ex3																		
R3132x10Ex	VDD=VDET-0.1V IOL=+20μA	0.3									VDD≥VDET+0.1	0.75× VDD	VDD≥VDET+0.1	0.2× VDD	Topt=25°C	0.5	1.0	4.0
R3132x11Ex																		
R3132x12Ex																		
R3132x13Ex																		
R3132x14Ex			VDD=VDET-0.1V IOL=+750μA	0.3	VDD≥VDET+0.1	0.75× VDD	VDD≥VDET+0.1	0.2× VDD	Topt=25°C	0.5	1.0	4.0						
R3132x15Ex																		
R3132x16Ex																		
R3132x17Ex																		
R3132x18Ex																		
R3132x19Ex																		
R3132x20Ex																		
R3132x21Ex																		
R3132x22Ex																		
R3132x23Ex					VDD=VDET-0.1V IOL=+1.2mA	0.3	VDD≥VDET+0.1	0.75× VDD	VDD≥VDET+0.1	0.2× VDD	Topt=25°C	0.5	1.0	4.0				
R3132x24Ex																		
R3132x25Ex																		
R3132x26Ex																		
R3132x27Ex																		
R3132x28Ex																		
R3132x29Ex																		
R3132x30Ex																		
R3132x31Ex	VDD=VDET-0.1V IOL=+3.2mA	0.4	VDD≥VDET+0.1	0.75× VDD			VDD≥VDET+0.1	0.2× VDD	Topt=25°C	0.5	1.0	4.0						
R3132x32Ex																		
R3132x33Ex																		
R3132x34Ex																		
R3132x35Ex																		
R3132x36Ex																		
R3132x37Ex																		
R3132x38Ex																		
R3132x39Ex																		
R3132x40Ex																		
R3132x41Ex																		
R3132x42Ex																		
R3132x43Ex																		
R3132x44Ex																		
R3132x45Ex																		
R3132x46Ex																		
R3132x47Ex																		
R3132x48Ex																		
R3132x49Ex																		
R3132x50Ex																		

\* R3133Q (SC-82AB) is the discontinued product as of March, 2016.

R3132x/R3133x

Output Delay Time for Release				Detector Threshold Temperature Coefficient	
Tdelay[ms]				$\Delta V_{DET}/\Delta T_{opt}$ [ppm/°C]	
Conditions	Min.	Typ.	Max.	Conditions	Typ.
V <sub>DD</sub> =0.8V→ V <sub>DET</sub> +1.0V T <sub>opt</sub> =25°C	204	240	276	-40°C≤T <sub>opt</sub> ≤85°C	±100
V <sub>DD</sub> =0.8V→ V <sub>DET</sub> +1.0V T <sub>opt</sub> =25°C	204	240	276	-40°C≤T <sub>opt</sub> ≤85°C	±100

\* R3133Q (SC-82AB) is the discontinued product as of March, 2016.

## R3132x/R3133x

### ● R3133x

Part Number	Operating Voltage				Detector Threshold			Supply Current 1		
	V <sub>DD</sub> [V]				V <sub>DET</sub> [V]			I <sub>SS1</sub> [μA]		
	Conditions	Min.	Conditions	Min.	Min.	Typ.	Max.	Conditions	Typ.	Max.
R3133x23Ex2	T <sub>opt</sub> =25°C	0.80	-40°C≤T <sub>opt</sub> ≤85°C	0.90	2.274	2.320	2.366	V <sub>DD</sub> =V <sub>DET</sub> -0.1V I <sub>OUT</sub> =0A	0.8	2.0
R3133x26Ex3					2.578	2.630	2.682			
R3133x29Ex3					2.872	2.930	2.988			
R3133x30Ex8					3.019	3.080	3.141			
R3133x43Ex8					4.293	4.380	4.467			
R3133x46Ex3					4.538	4.630	4.722			
R3133x10Ex	T <sub>opt</sub> =25°C	0.80	-40°C≤T <sub>opt</sub> ≤85°C	0.90	0.980	1.000	1.020	V <sub>DD</sub> =V <sub>DET</sub> -0.1V I <sub>OUT</sub> =0A	0.8	2.0
R3133x11Ex					1.078	1.100	1.122			
R3133x12Ex					1.176	1.200	1.224			
R3133x13Ex					1.274	1.300	1.326			
R3133x14Ex					1.372	1.400	1.428			
R3133x15Ex					1.470	1.500	1.530			
R3133x16Ex					1.568	1.600	1.632			
R3133x17Ex					1.666	1.700	1.734			
R3133x18Ex					1.764	1.800	1.836			
R3133x19Ex					1.862	1.900	1.938			
R3133x20Ex					1.960	2.000	2.040			
R3133x21Ex					2.058	2.100	2.142			
R3133x22Ex					2.156	2.200	2.244			
R3133x23Ex					2.254	2.300	2.346			
R3133x24Ex					2.352	2.400	2.448			
R3133x25Ex					2.450	2.500	2.550			
R3133x26Ex					2.548	2.600	2.652			
R3133x27Ex					2.646	2.700	2.754			
R3133x28Ex					2.744	2.800	2.856			
R3133x29Ex					2.842	2.900	2.958			
R3133x30Ex					2.940	3.000	3.060		0.9	
R3133x31Ex					3.038	3.100	3.162			
R3133x32Ex					3.136	3.200	3.264			
R3133x33Ex					3.234	3.300	3.366			
R3133x34Ex					3.332	3.400	3.468			
R3133x35Ex					3.430	3.500	3.570			
R3133x36Ex					3.528	3.600	3.672			
R3133x37Ex					3.626	3.700	3.774			
R3133x38Ex					3.724	3.800	3.876			
R3133x39Ex					3.822	3.900	3.978			
R3133x40Ex					3.920	4.000	4.080			
R3133x41Ex					4.018	4.100	4.182			
R3133x42Ex					4.116	4.200	4.284			
R3133x43Ex					4.214	4.300	4.386			
R3133x44Ex	4.312	4.400	4.488							
R3133x45Ex	4.410	4.500	4.590							
R3133x46Ex	4.508	4.600	4.692							
R3133x47Ex	4.606	4.700	4.794							
R3133x48Ex	4.704	4.800	4.896							
R3133x49Ex	4.802	4.900	4.998							
R3133x50Ex	4.900	5.000	5.100							

Supply Current 2			Supply Current 3			"H" Output Voltage	
Iss2[ $\mu$ A]			Iss3[ $\mu$ A]			VoH[V]	
Conditions	Typ.	Max.	Conditions	Typ.	Max.	Conditions	Min.
VDD=VDET+0.1V IOU=0A	0.8	2.0	VDD=6.0V IOU=0A	1.2	3.0	VDD=VDET-0.1V IOH=-500 $\mu$ A	0.8 $\times$ VDD
				1.0	2.5	VDD=VDET-0.1V IOH=-800 $\mu$ A	
VDD=VDET+0.1V IOU=0A	0.8	2.0	VDD=6.0V IOU=0A	1.4	3.6	VDD=VDET-0.1V IOH=-10 $\mu$ A	0.8 $\times$ VDD
					VDD=VDET-0.1V IOH=-100 $\mu$ A		
				1.2	3.0	VDD=VDET-0.1V IOH=-500 $\mu$ A	
					VDD=VDET-0.1V IOH=-800 $\mu$ A		
				1.0	2.5	VDD=VDET-0.1V IOH=-800 $\mu$ A	

\* R3133Q (SC-82AB) is the discontinued product as of March, 2016.

## R3132x/R3133x

Part Number	"L" Output Voltage		MR pin "H" Input Voltage		MR pin "L" Input Voltage		MR pin pull-up resistance			
	V <sub>OL</sub> [V]		V <sub>IH</sub> [V]		V <sub>IL</sub> [V]		R <sub>MR</sub> [MΩ]			
	Conditions	Max.	Conditions	Min.	Conditions	Max.	Conditions	Min.	Typ.	Max.
R3133x23Ex2	V <sub>DD</sub> =V <sub>DET</sub> +0.1V I <sub>OL</sub> =+1.2mA	0.3	V <sub>DD</sub> ≥V <sub>DET</sub> +0.1	0.75× V <sub>DD</sub>	V <sub>DD</sub> ≥V <sub>DET</sub> +0.1	0.2× V <sub>DD</sub>	T <sub>opt</sub> =25°C	0.5	1.0	4.0
R3133x26Ex3										
R3133x29Ex3										
R3133x30Ex8										
R3133x43Ex8	V <sub>DD</sub> =V <sub>DET</sub> +0.1V I <sub>OL</sub> =+3.2mA	0.4	V <sub>DD</sub> ≥V <sub>DET</sub> +0.1	0.75× V <sub>DD</sub>	V <sub>DD</sub> ≥V <sub>DET</sub> +0.1	0.2× V <sub>DD</sub>	T <sub>opt</sub> =25°C	0.5	1.0	4.0
R3133x46Ex3										
R3133x10Ex	V <sub>DD</sub> =V <sub>DET</sub> +0.1V I <sub>OL</sub> =+20μA	0.3	V <sub>DD</sub> ≥V <sub>DET</sub> +0.1	0.75× V <sub>DD</sub>	V <sub>DD</sub> ≥V <sub>DET</sub> +0.1	0.2× V <sub>DD</sub>	T <sub>opt</sub> =25°C	0.5	1.0	4.0
R3133x11Ex										
R3133x12Ex	V <sub>DD</sub> =V <sub>DET</sub> +0.1V I <sub>OL</sub> =+750μA	0.3	V <sub>DD</sub> ≥V <sub>DET</sub> +0.1	0.75× V <sub>DD</sub>	V <sub>DD</sub> ≥V <sub>DET</sub> +0.1	0.2× V <sub>DD</sub>	T <sub>opt</sub> =25°C	0.5	1.0	4.0
R3133x13Ex										
R3133x14Ex										
R3133x15Ex										
R3133x16Ex										
R3133x17Ex										
R3133x18Ex										
R3133x19Ex										
R3133x20Ex										
R3133x21Ex										
R3133x22Ex	V <sub>DD</sub> =V <sub>DET</sub> +0.1V I <sub>OL</sub> =+1.2mA	0.3	V <sub>DD</sub> ≥V <sub>DET</sub> +0.1	0.75× V <sub>DD</sub>	V <sub>DD</sub> ≥V <sub>DET</sub> +0.1	0.2× V <sub>DD</sub>	T <sub>opt</sub> =25°C	0.5	1.0	4.0
R3133x23Ex										
R3133x24Ex										
R3133x25Ex										
R3133x26Ex										
R3133x27Ex										
R3133x28Ex										
R3133x29Ex										
R3133x30Ex										
R3133x31Ex										
R3133x32Ex										
R3133x33Ex										
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R3133x41Ex										
R3133x42Ex										
R3133x43Ex										
R3133x44Ex										
R3133x45Ex										
R3133x46Ex										
R3133x47Ex										
R3133x48Ex										
R3133x49Ex										
R3133x50Ex										

\* R3133Q (SC-82AB) is the discontinued product as of March, 2016.

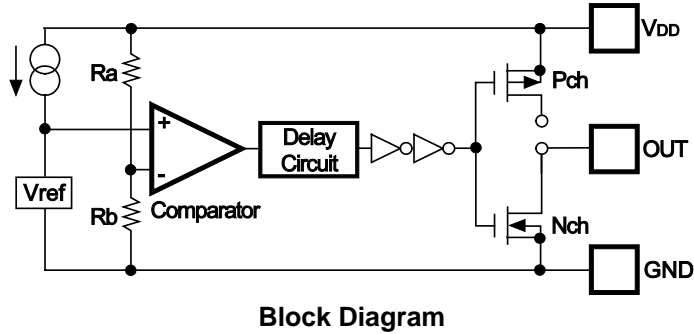
R3132x/R3133x

Output Delay Time for Release				Detector Threshold Temperature Coefficient	
Tdelay[ms]				$\Delta V_{DET}/\Delta T_{opt}$ [ppm/°C]	
Conditions	Min.	Typ.	Max.	Conditions	Typ.
V <sub>DD</sub> =0.8V→ V <sub>DET</sub> +1.0V T <sub>opt</sub> =25°C	204	240	276	-40°C≤T <sub>opt</sub> ≤85°C	±100
V <sub>DD</sub> =0.8V→ V <sub>DET</sub> +1.0V T <sub>opt</sub> =25°C	204	240	276	-40°C≤T <sub>opt</sub> ≤85°C	±100

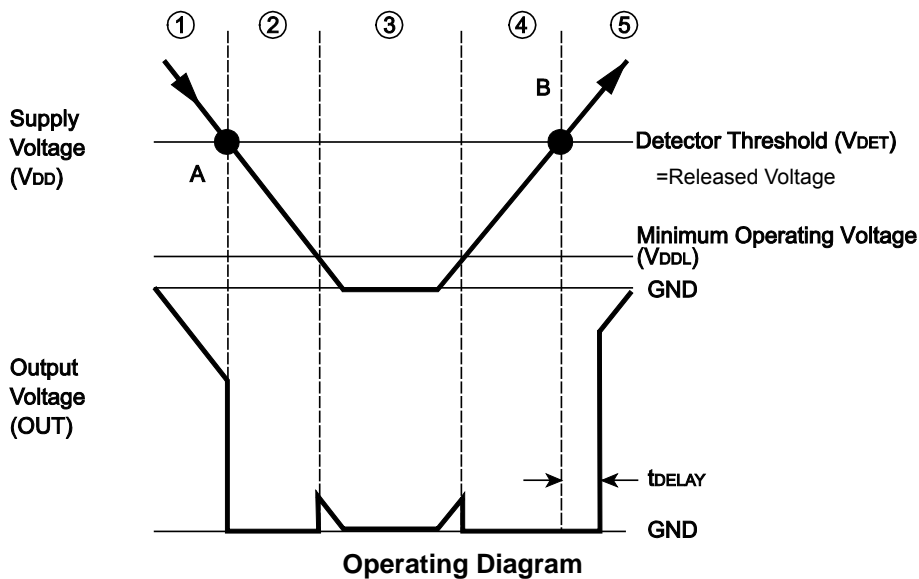
## R3132x/R3133x

### OPERATION

#### • Operation of R3132x Series



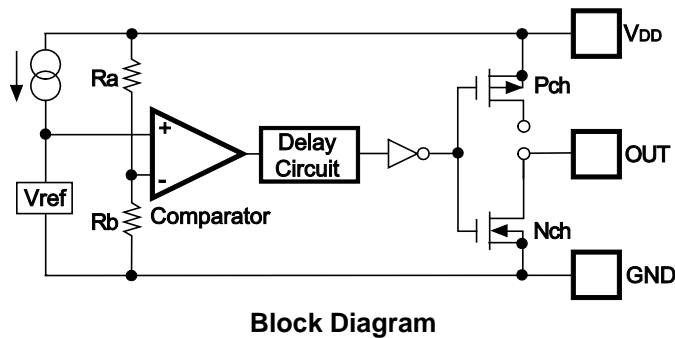
- CMOS Output Type:  
OUT pin is connected to the drain of Nch Tr. and Pch Tr. in this IC.
- Nch Open Drain Output Type:  
OUT pin is connected to the drain of Nch Tr. in this IC.  
(OUT pin should be pulled up to  $V_{DD}$  or an external voltage level.)



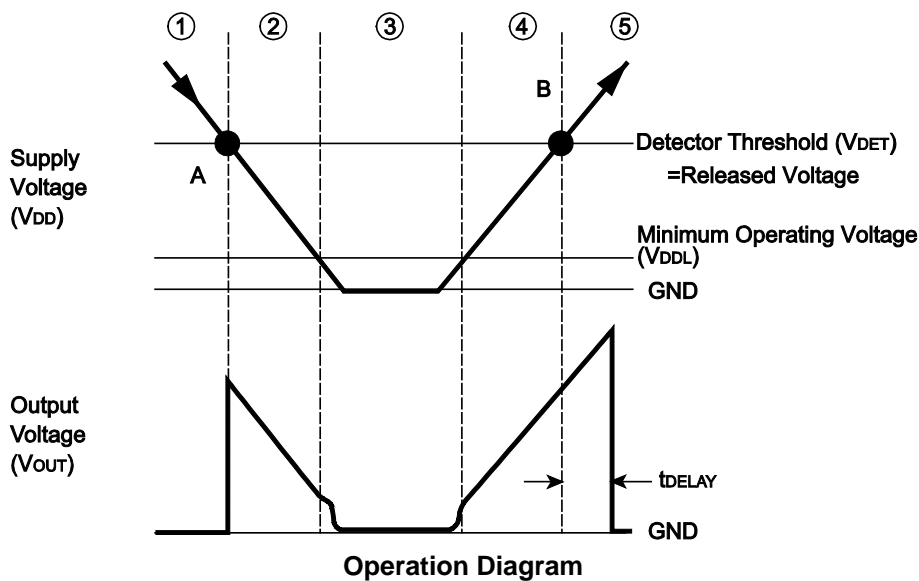
In the above diagram,

- ① Output voltage becomes equal to supply voltage (Nch open drain output type; equal to pull-up Voltage).
  - ② When the supply voltage is down to the detector threshold level (Point A),  $V_{ref} \geq V_{DD} \times R_b / (R_a + R_b)$  is true. Then, the output of the comparator is reversed, thus output voltage becomes equal to GND level.
  - ③ When the supply voltage is lower than minimum operating voltage, the output of transistor is indefinite, therefore the output is also indefinite.
  - ④ Output voltage is equal to GND level.
  - ⑤ When the supply voltage is higher than the released voltage (Point B),  $V_{ref} \leq V_{DD} \times R_b / (R_a + R_b)$  is true. Then the output of the comparator is reversed, thus the output voltage becomes equal to the supply voltage (Nch open drain output type; equal to pull-up voltage).
- \* There is no hysteresis range between the detector threshold and the released voltage.

• Operation of R3133x Series



- CMOS Output Type:  
Out pin is connected to the drain of Nch Tr. and Pch Tr. in this IC.
- Nch Open Drain Output Type:  
Out pin is connected to the drain of Nch Tr. in this IC.  
(OUT pin should be pulled up to V<sub>DD</sub> or an external voltage level.)



In the above diagram,

- ① Output voltage becomes equal to GND level.
- ② When the supply voltage is down to the detector threshold level (Point A),  $V_{ref} \geq V_{DD} \times R_b / (R_a + R_b)$  is true. Then, the output of the comparator is reversed, thus output voltage becomes equal to the supply voltage (Nch open drain output type; equal to pull-up voltage).
- ③ When the supply voltage is lower than minimum operating voltage, the output of transistor is indefinite, therefore the output is also indefinite. (Nch open drain output type; the output voltage level is equal to pull-up voltage.)
- ④ Output voltage is equal to the supply voltage. (Nch open drain output type; equal to pull-up Voltage.)
- ⑤ When the supply voltage is higher than the released voltage (Point B),  $V_{ref} \leq V_{DD} \times R_b / (R_a + R_b)$  is true. Then the output of the comparator is reversed, thus the output voltage becomes equal to GND level after the output delay time.

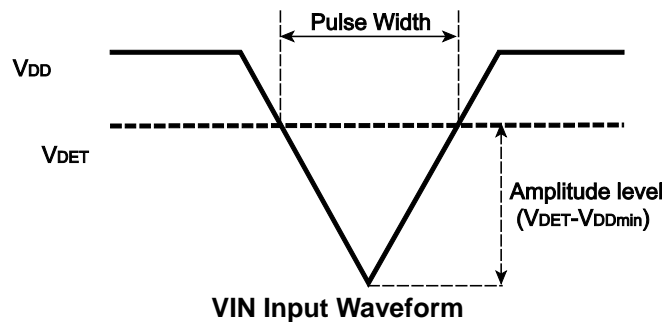
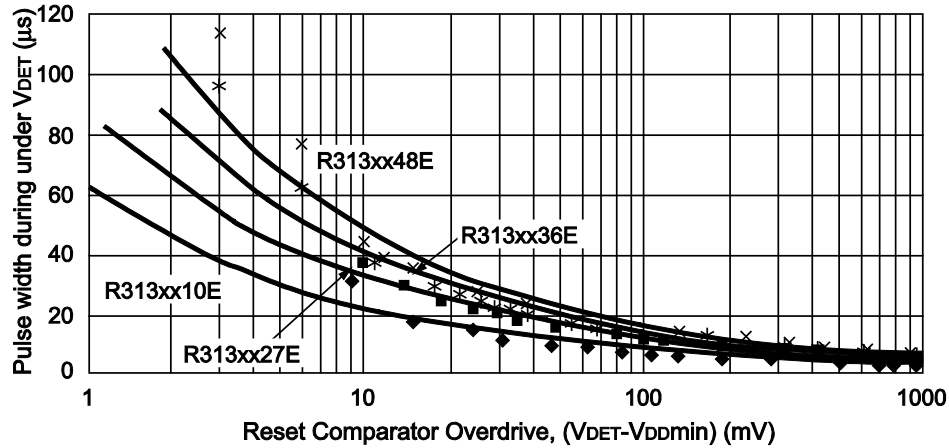
\* There is no hysteresis range between the detector threshold and the released voltage.



## R3132x/R3133x

### TECHNICAL NOTES

When the IC is released, if a large pulse (glitch) which crosses the detector threshold voltage is in, the IC may not maintain the released condition. The amplitude of the pulse ( $V_{DET}-V_{DDmin}$ ) and the pulse width the IC can maintain the released level is described in the graph as follows:



#### Notes:

The graph above shows the condition for the maximum transient duration without generating a reset. If the larger amplitude or larger pulse width noise than the graph may be on the  $V_{DD}$ , the reset signal may be generated.

### When connecting resistors to the device's input pin

When connecting a resistor (R1) to an input of this device, the input voltage decreases by [Device's Consumption Current] x [Resistance Value] only. And, the cross conduction current\*<sup>1</sup>, which occurs when changing from the detecting state to the release state, is decreased the input voltage by [Cross Conduction Current] x [Resistance Value] only. And then, this device will enter the re-detecting state if the input voltage reduction is larger than the difference between the detector voltage and the released voltage.

When the input resistance value is large and the VDD is gone up at mildly in the vicinity of the released voltage, repeating the above operation may result in the occurrence of output.

As shown in Figure A/B, set R1 to become 100 kΩ or less as a guide, and connect C<sub>IN</sub> of 0.1 μF and more to between the input pin and GND. Besides, make evaluations including temperature properties under the actual usage condition, with using the evaluation board like this way. As a result, make sure that the cross conduction current has no problem.

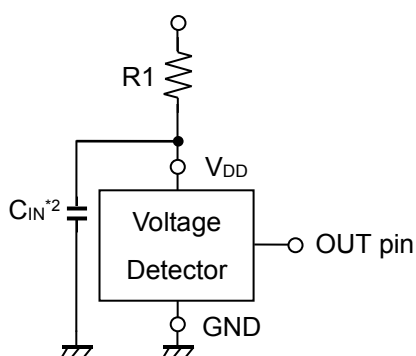


Figure A

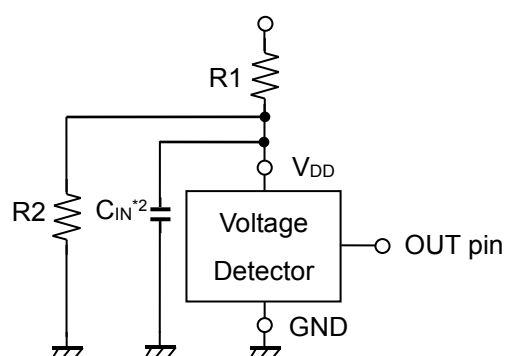


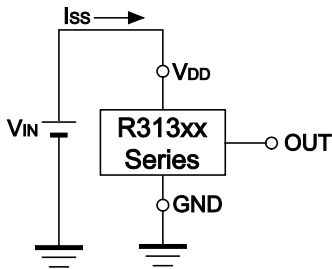
Figure B

\*<sup>1</sup> In the CMOS output type, a charging current for OUT pin is included.

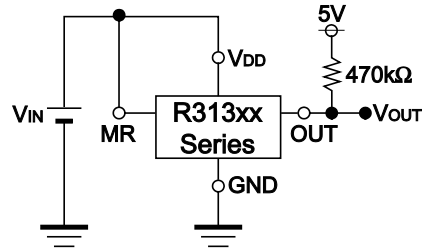
\*<sup>2</sup> Note the bias dependence of capacitors.

R3132x/R3133x

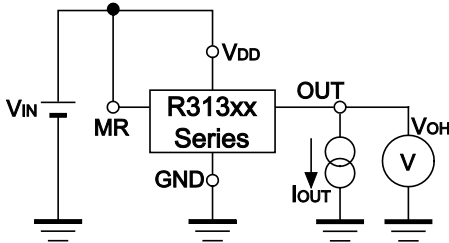
TEST CIRCUITS



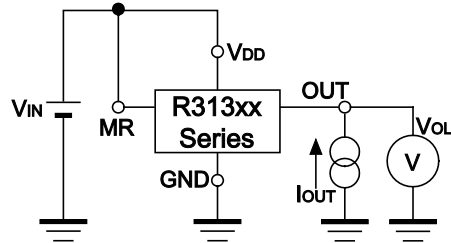
Supply Current Test Circuit



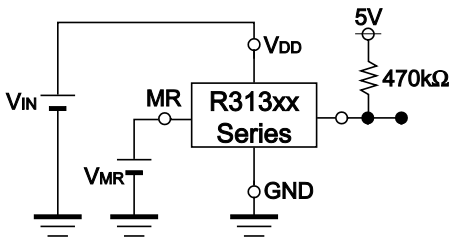
Detector Threshold Test Circuit  
(CMOS Output type; pull-up part is not necessary.)



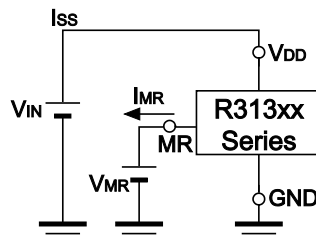
"H" Output Voltage Test Circuit  
(CMOS Output Type only)



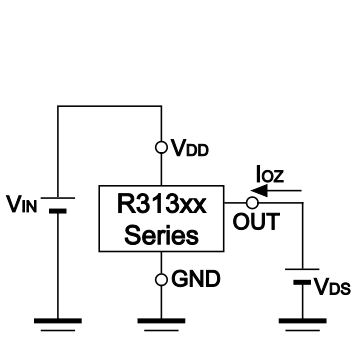
"L" Output Voltage Test Circuit



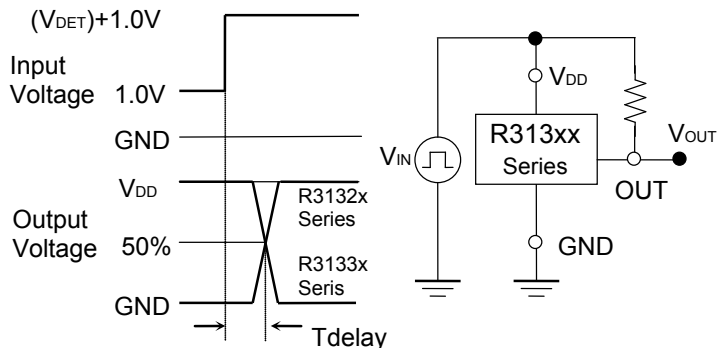
MR pin Input Voltage Test Circuit  
(CMOS Output type; pull-up part is not necessary.)



MR pin Pull-up Resistance Test Circuit



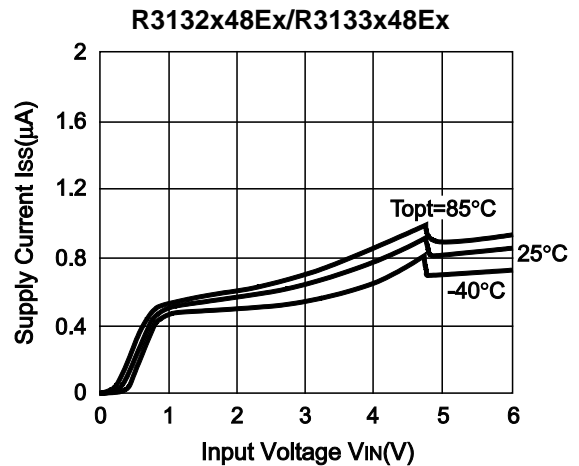
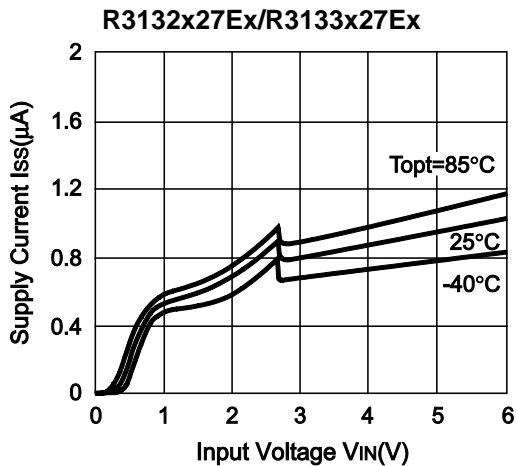
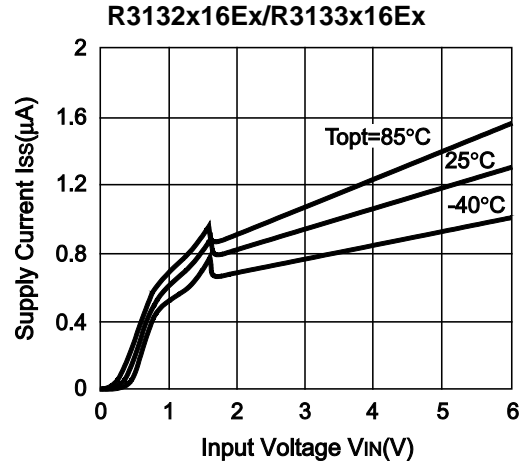
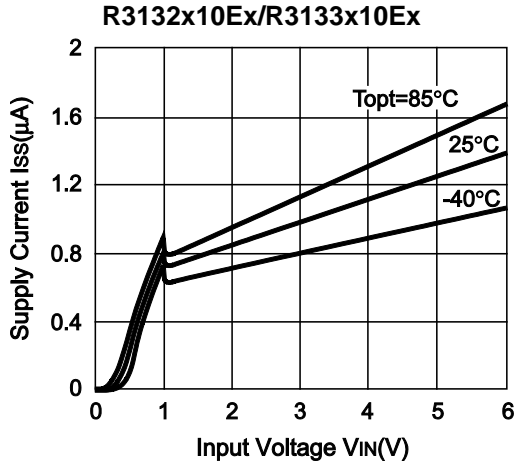
Off Leakage Current Test Circuit



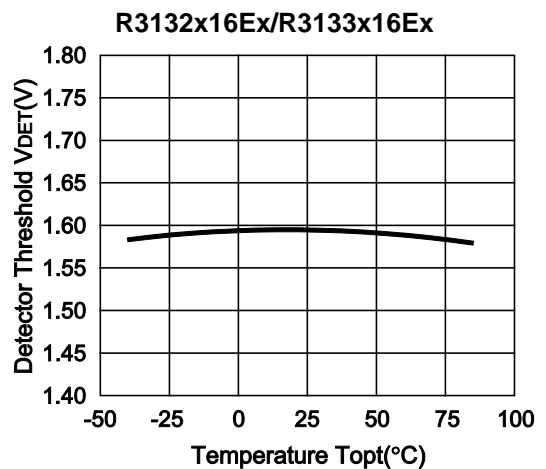
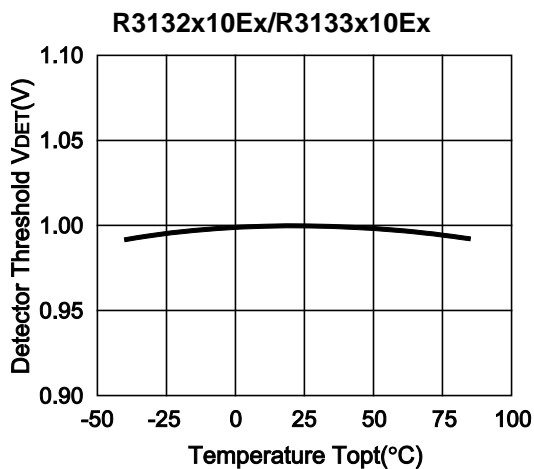
Output Delay Time Test Circuit  
(CMOS Output type; pull-up is not necessary.)

## TYPICAL CHARACTERISTICS

### 1) Supply Current vs. Input Voltage

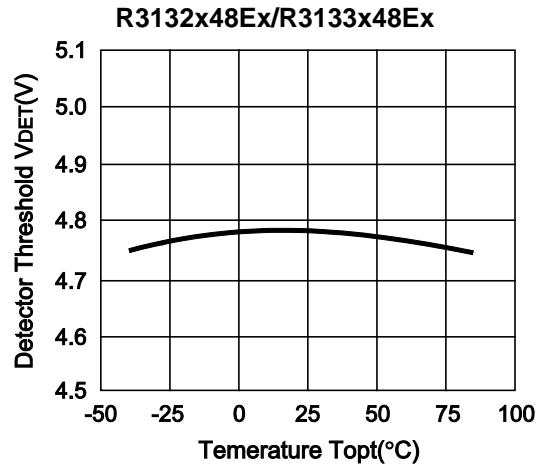
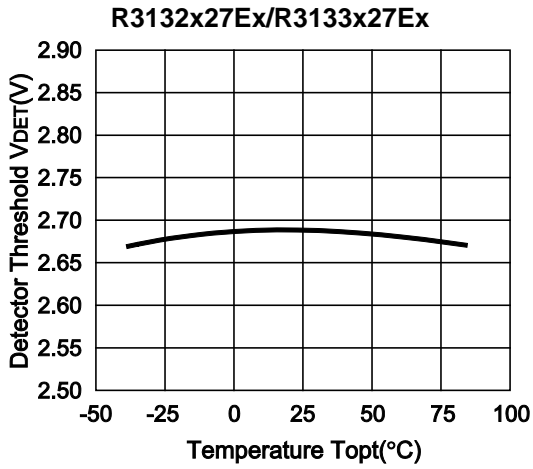


### 2) Detector Threshold vs. Temperature

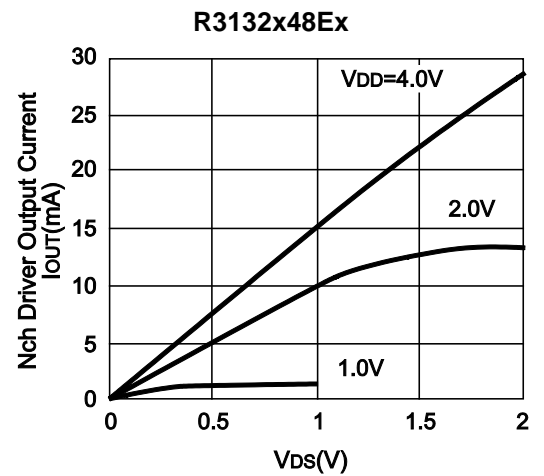
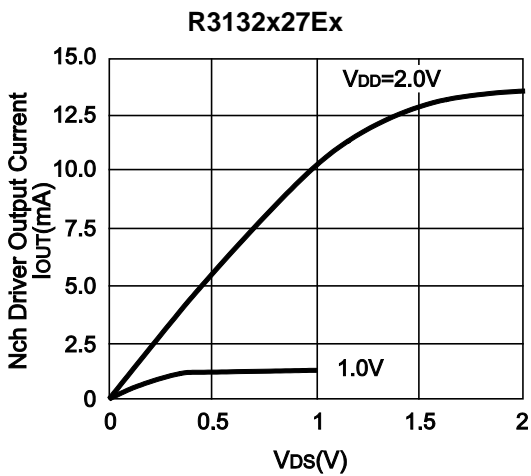
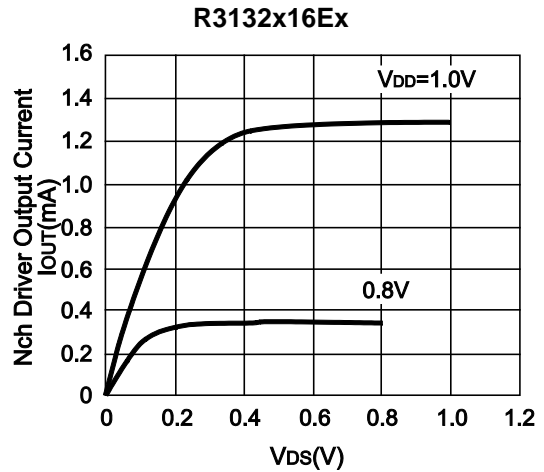
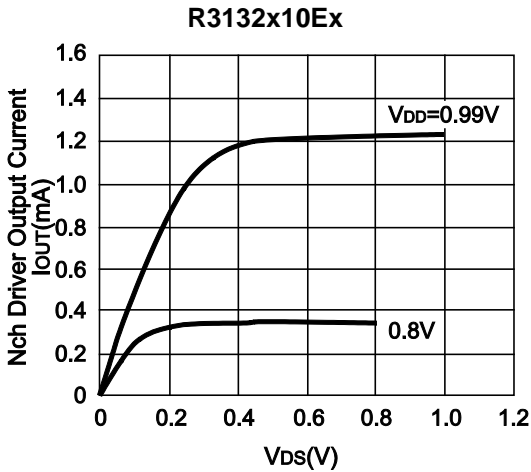


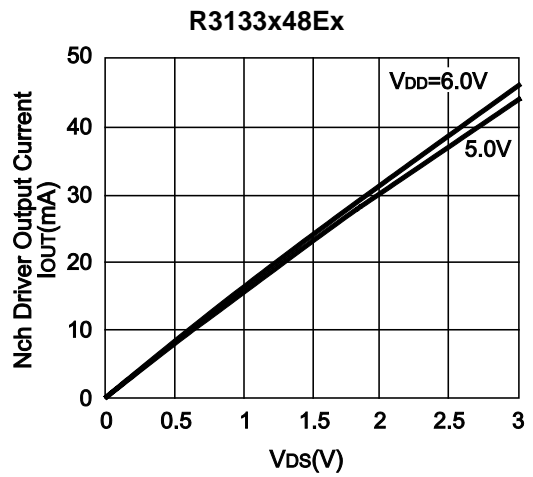
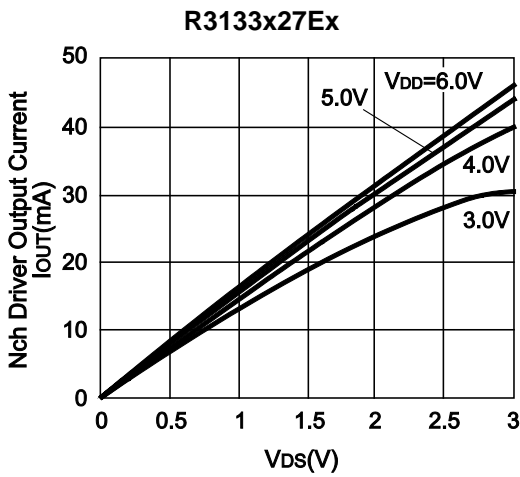
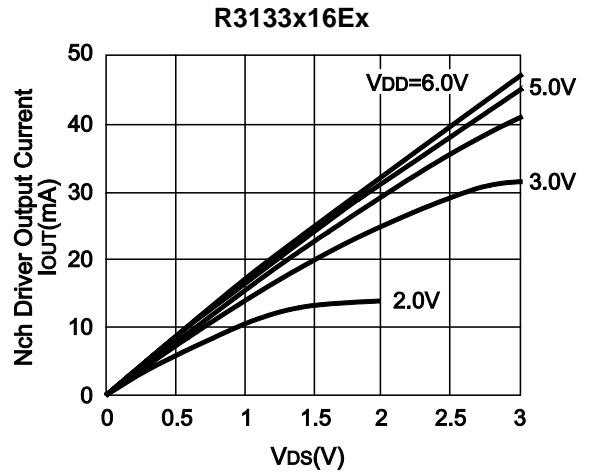
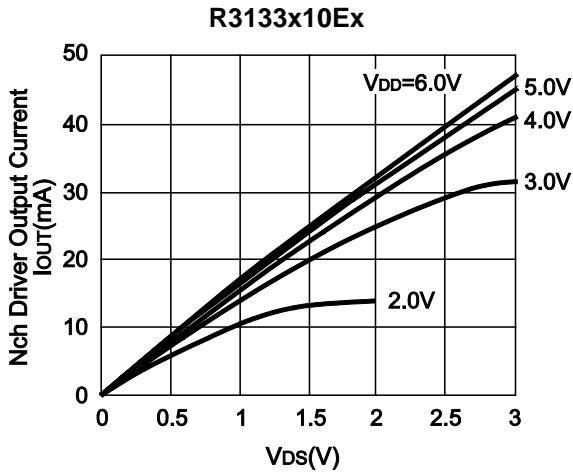
\* R3133Q (SC-82AB) is the discontinued product as of March, 2016.

R3132x/R3133x

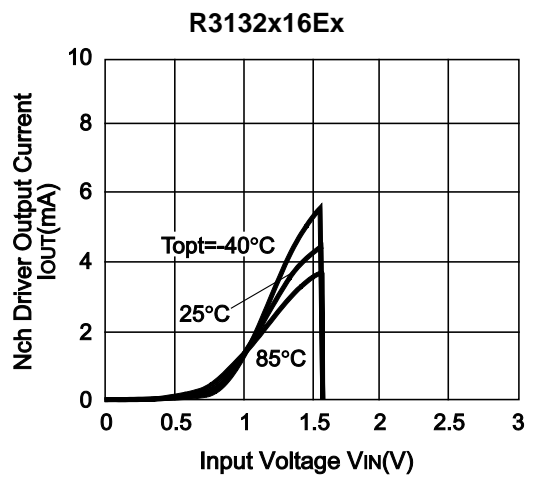
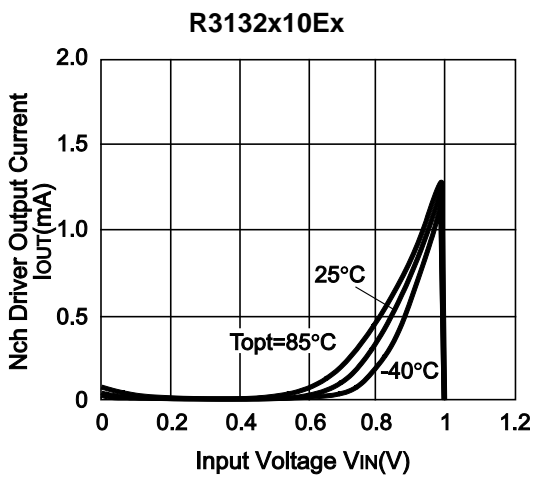


3) Nch Driver Output Current vs. V<sub>DS</sub> (T<sub>opt</sub>=25°C)

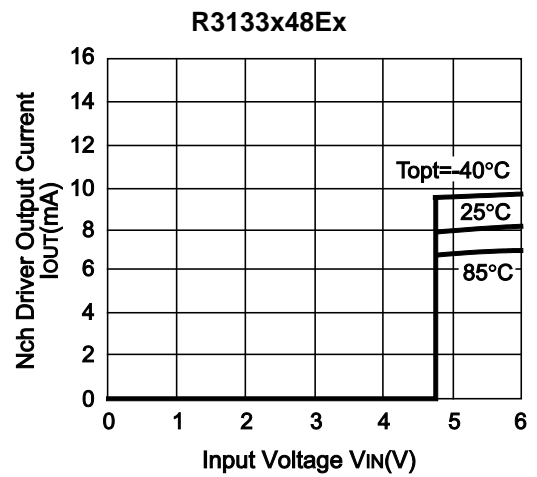
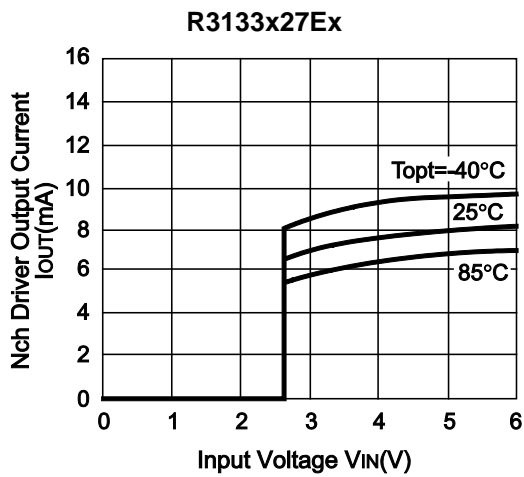
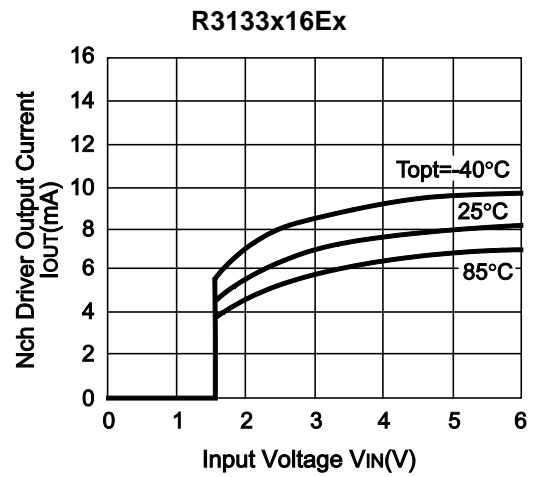
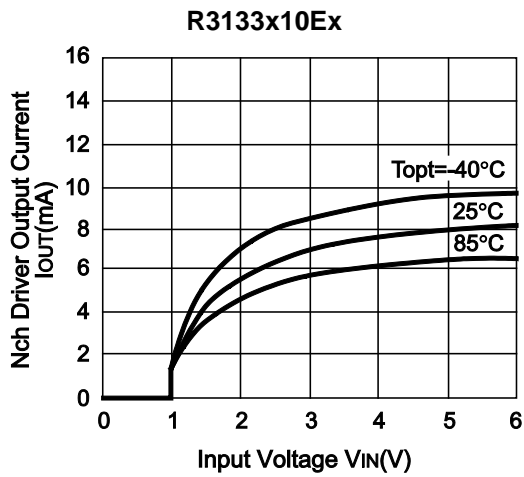
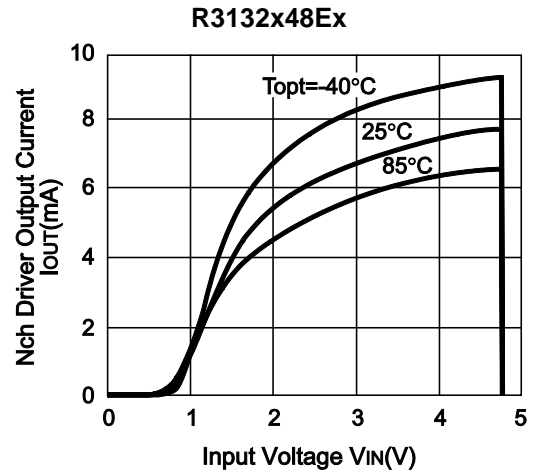
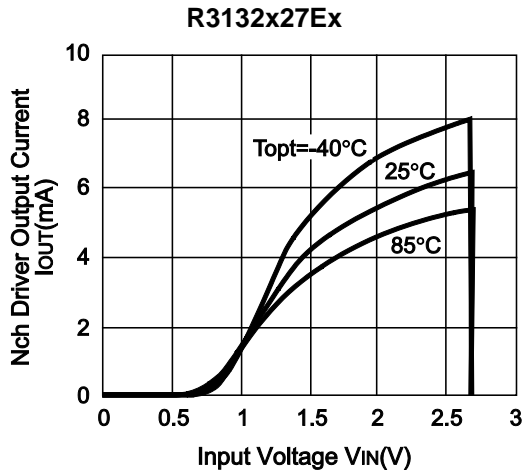




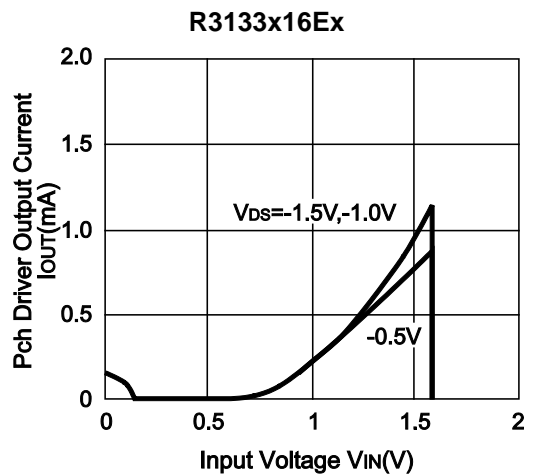
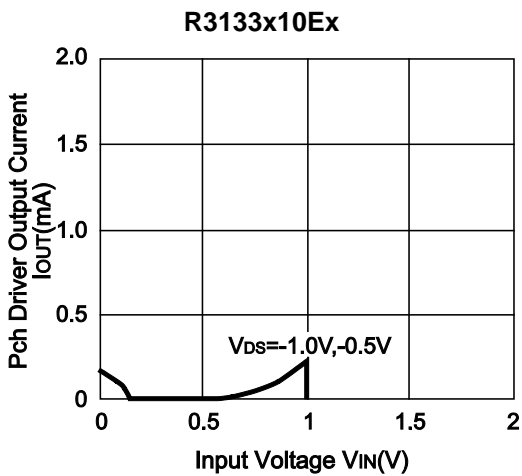
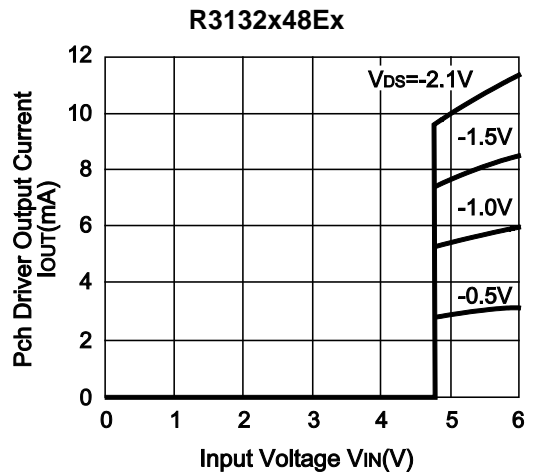
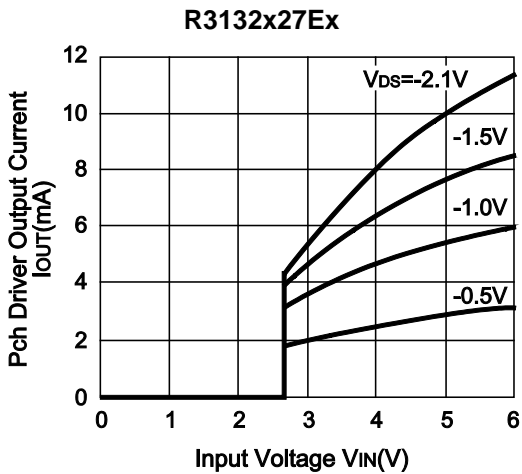
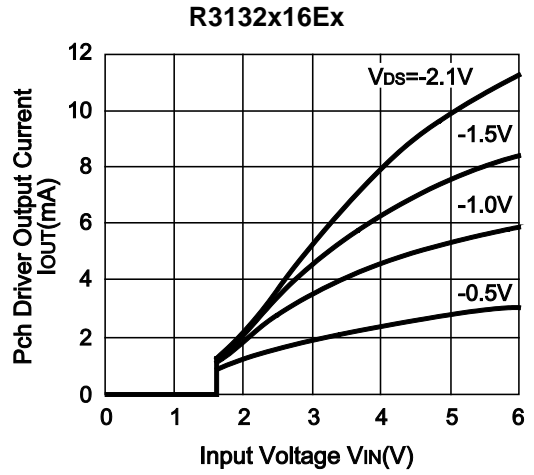
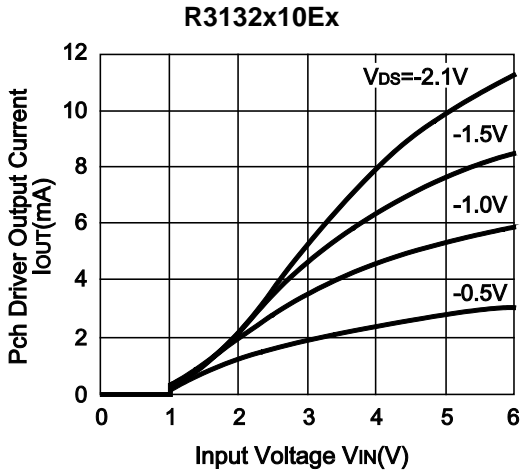
4) Nch Driver Output Current vs. Input Voltage ( $V_{DS}=0.5V$ )



R3132x/R3133x



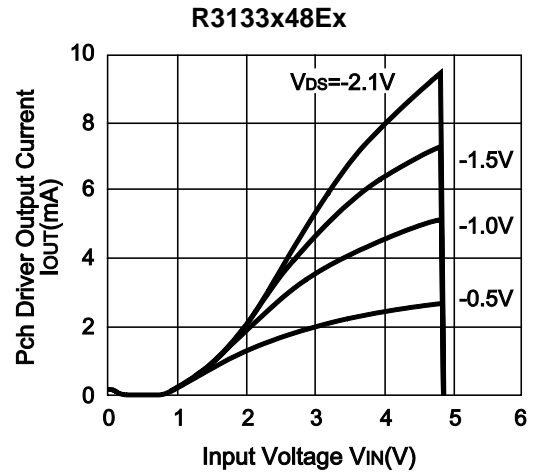
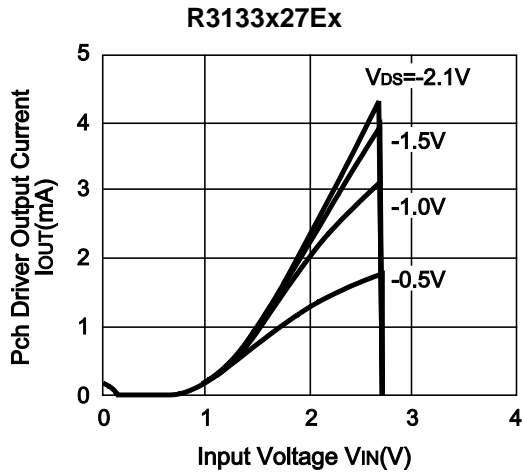
5) Pch Driver Output Current vs. Input Voltage



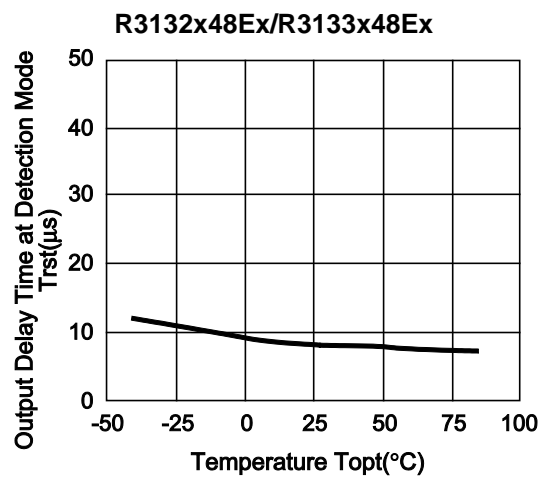
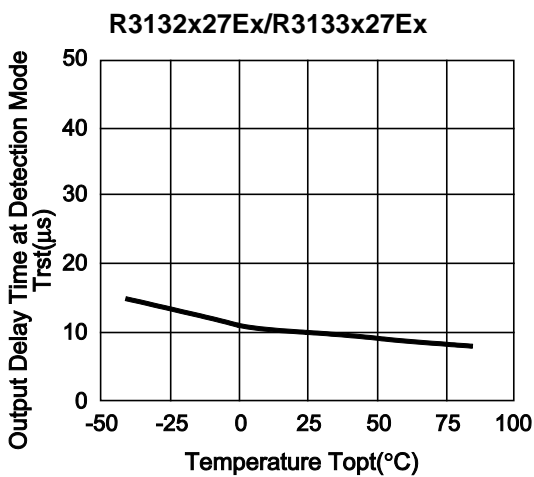
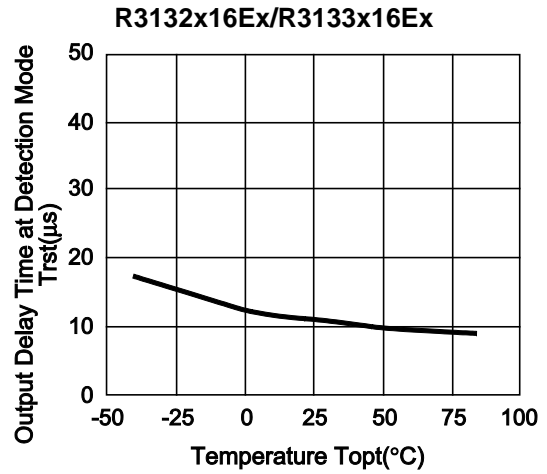
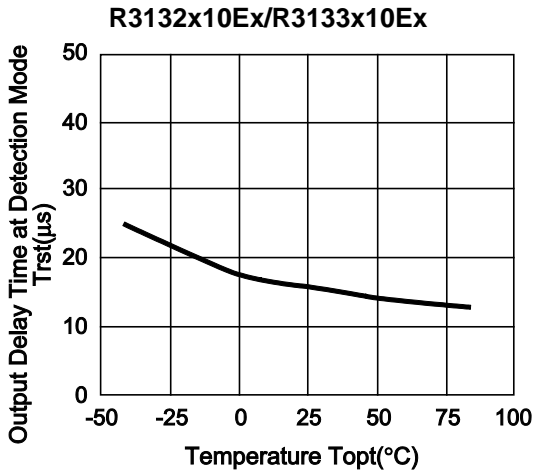


\* R3133Q (SC-82AB) is the discontinued product as of March, 2016.

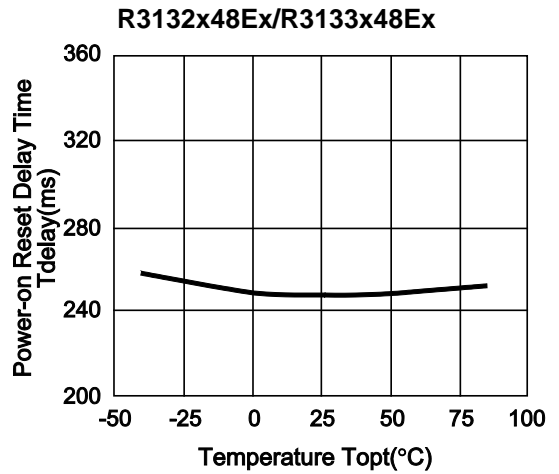
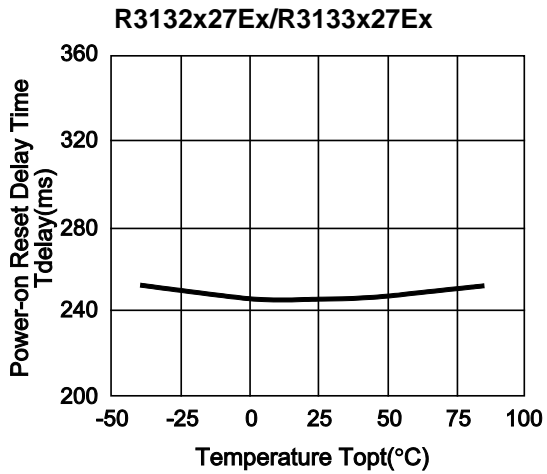
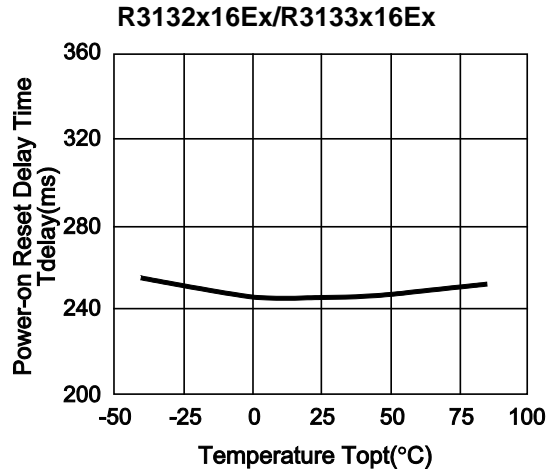
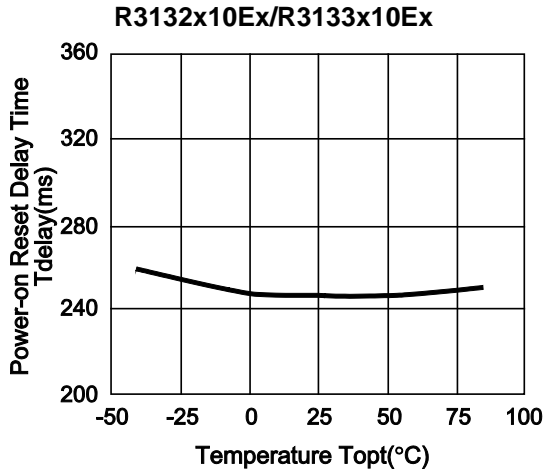
R3132x/R3133x



6) Output Delay Time at Detection Mode vs. Temperature



7) Power-on Reset Delay Time vs. Temperature





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5. The products listed in this document are intended and designed for use as general electronic components in standard applications (office equipment, telecommunication equipment, measuring instruments, consumer electronic products, amusement equipment etc.). Those customers intending to use a product in an application requiring extreme quality and reliability, for example, in a highly specific application where the failure or misoperation of the product could result in human injury or death (aircraft, spacevehicle, nuclear reactor control system, traffic control system, automotive and transportation equipment, combustion equipment, safety devices, life support system etc.) should first contact us.
6. We are making our continuous effort to improve the quality and reliability of our products, but semiconductor products are likely to fail with certain probability. In order to prevent any injury to persons or damages to property resulting from such failure, customers should be careful enough to incorporate safety measures in their design, such as redundancy feature, fire containment feature and fail-safe feature. We do not assume any liability or responsibility for any loss or damage arising from misuse or inappropriate use of the products.
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8. The X-ray exposure can influence functions and characteristics of the products. Confirm the product functions and characteristics in the evaluation stage.
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10. There can be variation in the marking when different AOI (Automated Optical Inspection) equipment is used. In the case of recognizing the marking characteristic with AOI, please contact Ricoh sales or our distributor before attempting to use AOI.
11. Please contact Ricoh sales representatives should you have any questions or comments concerning the products or the technical information.



**Ricoh is committed to reducing the environmental loading materials in electrical devices with a view to contributing to the protection of human health and the environment.**

Ricoh has been providing RoHS compliant products since April 1, 2006 and Halogen-free products since April 1, 2012.

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